

flow 2xBOOST 0 / flow 3xBOOST 0		600 V / 41 mΩ
Features		flow 0 12 mm housing
<ul style="list-style-type: none"> • High efficiency dual or triple booster • Low Inductance Layout • Ultra fast switching frequency 		
Target Applications		Schematic
<ul style="list-style-type: none"> • Solar inverter 		
Types		
<ul style="list-style-type: none"> • 10-FZ063BA040MF-M575L08 (triple booster) • 10-FZ06B2A040MF01-M575L28 (dual booster) 		

Maximum Ratings

$T_j = 25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Boost Switch (T1*, T2, T3)				
Drain to source breakdown voltage	V_{DS}		600	V
DC drain current	I_D	$T_j = T_{jmax}$	32	A
Pulsed drain current	I_{Dpulse}	t_p limited by T_{jmax}	272	A
MOSFET dv/dt ruggedness	dv / dt	$V_{DS}=0...480\text{V}$	50	V/ns
Power dissipation	P_{tot}	$T_j = T_{jmax}$	97	W
Gate-source peak voltage	V_{GSS}		± 20	V
Reverse diode dv/dt	dv / dt		15	V/ns
Maximum Junction Temperature	T_{jmax}		150	$^\circ\text{C}$

*not assembled in 10-FZ06B2A040MF01-M575L28

Boost Diode (D1*, D2, D3)

Peak Repetitive Reverse Voltage	V_{RRM}		600	V
DC forward current	I_F	$T_j = T_{jmax}$	38	A
Repetitive peak forward current	I_{FSM}	60Hz Single Half-Sine Wave	300	A
Power dissipation	P_{tot}	$T_j = T_{jmax}$	57	W
Maximum Junction Temperature	T_{jmax}		175	$^\circ\text{C}$

*not assembled in 10-FZ06B2A040MF01-M575L28

DC Link Capacitance (C1, C2)

Max.DC voltage	V_{MAX}	$T_c = 25^\circ\text{C}$	630	V
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Thermal Properties

Storage temperature	T_{stg}		-40...+125	$^\circ\text{C}$
Operation temperature under switching condition	T_{op}		-40...+($T_{jmax} - 25$)	$^\circ\text{C}$

Insulation Properties

Insulation voltage	V_{is}	$t = 2\text{ s}$	DC Test Voltage*	6000	V
		$t = 1\text{ min}$	AC Voltage	2500	
Creepage distance				>12,7	mm
Clearance				>12,7	mm
Comparative tracking index	CTI			>200	

* 100% tested in production



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10-FZ06B2A040MF01-M575L28

datasheet

Characteristic Values

Parameter	Symbol	Conditions						Value			Unit			
		V_{GE} [V]	V_r [V]	I_c [A]	I_F [A]	T_j [$^{\circ}$ C]	I_D [A]	Min	Typ	Max				
Boost Switch (T1*, T2, T3)														
Static drain to source ON resistance	$r_{DS(on)}$		10		44,4	25 125		41 85	51,8		mΩ			
Gate threshold voltage	$V_{(GS)th}$	$V_{CE} = V_{GE}$			0,00296	25		2,4	3	3,6	V			
Gate to Source Leakage Current	I_{GSS}		0	600		25				100	nA			
Zero Gate Voltage Drain Current	I_{DSS}		20	0		25				5000	nA			
Turn On Delay Time	$t_{d(on)}$	$R_{goff} = 8 \Omega$ $R_{gon} = 8 \Omega$	0/10	400	15	25 125		35 33			ns			
Rise Time	t_r					25 125		9 10						
Turn off delay time	$t_{d(off)}$					25 125		275 300						
Fall time	t_f					25 125		4 5						
Turn-on energy loss	E_{on}					25 125		0,18 0,34			mWs			
Turn-off energy loss	E_{off}					25 125		0,07 0,08						
Total gate charge	Q_{GE}					25		290			nC			
Gate to source charge	Q_{GS}					25		36						
Gate to drain charge	Q_{GD}					25		150						
Input capacitance	C_{iss}	$f = 1 \text{ MHz}$	0	25	44,4			6530			pF			
Output capacitance	C_{oss}							360						
Thermal resistance chip to heatsink	$R_{th(j-s)}$	Thermal grease thickness $\leq 50 \mu\text{m}$ $\lambda = 1 \text{ W/mK}$						0,72			K/W			
Boost Diode (D1*, D2, D3)														
Forward voltage	V_F				30	25 125		2,11 1,59	2,8		V			
Reverse leakage current	I_{rm}			300		25			100		μA			
Peak recovery current	I_{RRM}	$R_{gon} = 8 \Omega$	0/10	300	30	25 125		17,57 29,54			A			
Reverse recovery time	t_{rr}					25 125		14 32			ns			
Reverse recovery charge	Q_{rr}					25 125		0,15 0,56			μC			
Reverse recovered energy	E_{rec}					25 125		0,02 0,07			mWs			
Peak rate of fall of recovery current	$(di_{rf}/dt)_{max}$					25 125		5321 1723			A/μs			
Thermal resistance chip to heatsink	$R_{th(j-s)}$	Thermal grease thickness $\leq 50 \mu\text{m}$ $\lambda = 1 \text{ W/mK}$						1,67			K/W			
*not assembled in 10-FZ06B2A040MF01-M575L28														
DC Link Capacitance (C1, C2)														
C value	C							47			nF			
Thermistor														
Rated resistance	R					25		22			Ω			
Deviation of R_{100}	$\Delta R/R$	$R_{100} = 1486 \Omega$				25	-12		12		%			
Power dissipation	P				25			200			mW			
Power dissipation constant					25			2			mW/K			
B-value	$B_{(25/50)}$	Tol.±3%			25			3950			K			
B-value	$B_{(25/100)}$	Tol.±3%			25			3998			K			
Vincotech NTC Reference									B					



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10-FZ06B2A040MF01-M575L28

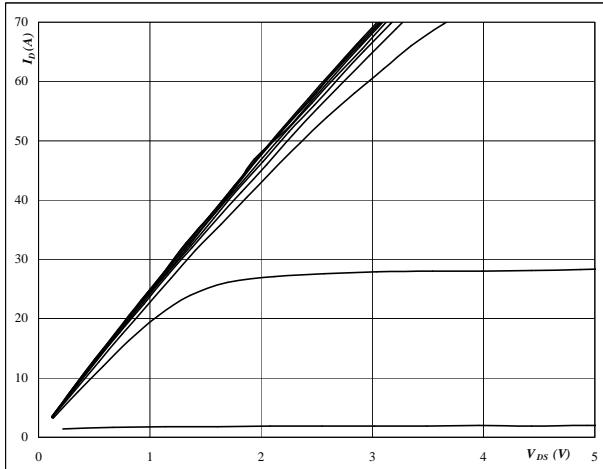
datasheet

Boost Switch (T1*, T2, T3) / Boost Diode (D1*, D2, D3)

*not assembled in 10-FZ06B2A040MF01-M575L28

figure 1. Boost Switch (T1*, T2, T3)**Typical output characteristics**

$$I_D = f(V_{DS})$$

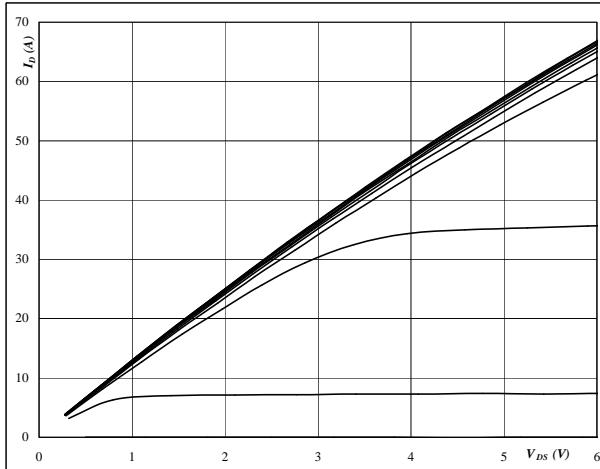
**At**

$$t_p = 250 \mu\text{s}$$

$$T_j = 25^\circ\text{C}$$

 V_{GS} from 3 V to 13 V in steps of 1 V**figure 2.** Boost Switch (T1*, T2, T3)**Typical output characteristics**

$$I_D = f(V_{DS})$$

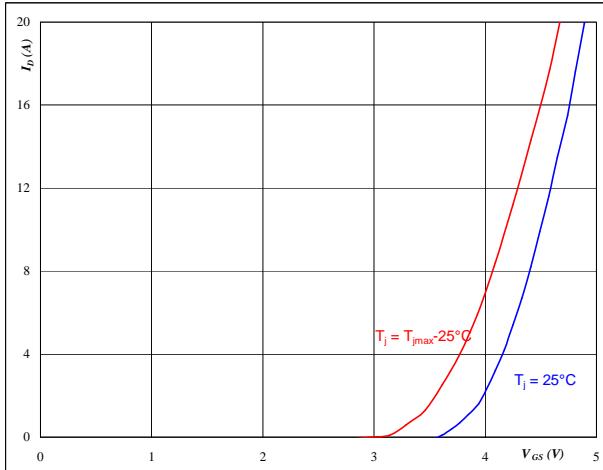
**At**

$$t_p = 250 \mu\text{s}$$

$$T_j = 125^\circ\text{C}$$

 V_{GS} from 3 V to 13 V in steps of 1 V**figure 3.** Boost Switch (T1*, T2, T3)**Typical transfer characteristics**

$$I_D = f(V_{GS})$$

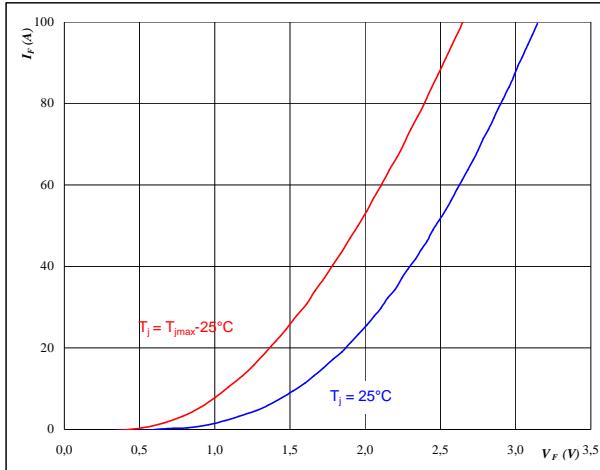
**At**

$$t_p = 250 \mu\text{s}$$

$$V_{DS} = 10 \text{ V}$$

figure 4. Boost Diode (D1*, D2, D3)**Typical diode forward current as a function of forward voltage**

$$I_F = f(V_F)$$

**At**

$$t_p = 250 \mu\text{s}$$

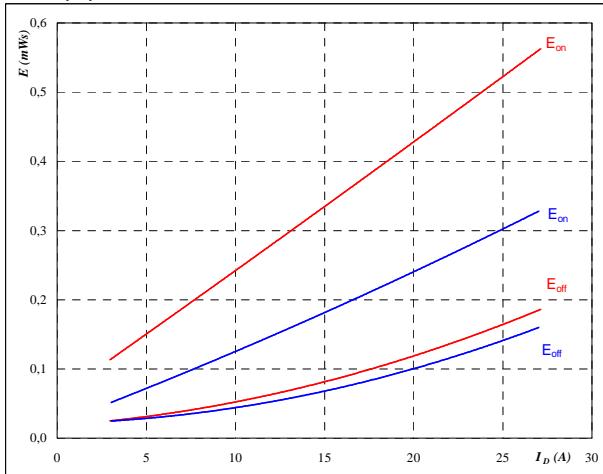
Boost Switch (T1*, T2, T3) / Boost Diode (D1*, D2, D3)

*not assembled in 10-FZ06B2A040MF01-M575L28

figure 5. Boost Switch (T1*, T2, T3)

Typical switching energy losses
as a function of drain current

$$E = f(I_D)$$



With an inductive load at

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_{DS} = 400 \text{ V}$$

$$V_{GS} = 0/10 \text{ V}$$

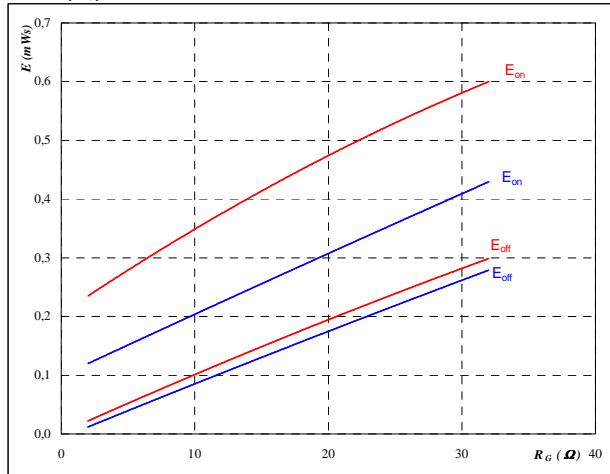
$$R_{gon} = 8 \text{ } \Omega$$

$$R_{goff} = 8 \text{ } \Omega$$

figure 6. Boost Switch (T1*, T2, T3)

Typical switching energy losses
as a function of gate resistor

$$E = f(R_G)$$



With an inductive load at

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_{DS} = 400 \text{ V}$$

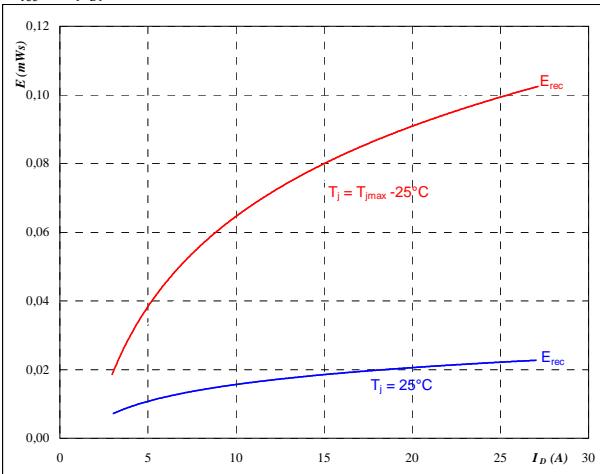
$$V_{GS} = 0/10 \text{ V}$$

$$I_D = 15 \text{ A}$$

figure 7. Boost Switch (T1*, T2, T3)

Typical reverse recovery energy loss
as a function of drain current

$$E_{rec} = f(I_D)$$



With an inductive load at

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_{DS} = 400 \text{ V}$$

$$V_{GS} = 0/10 \text{ V}$$

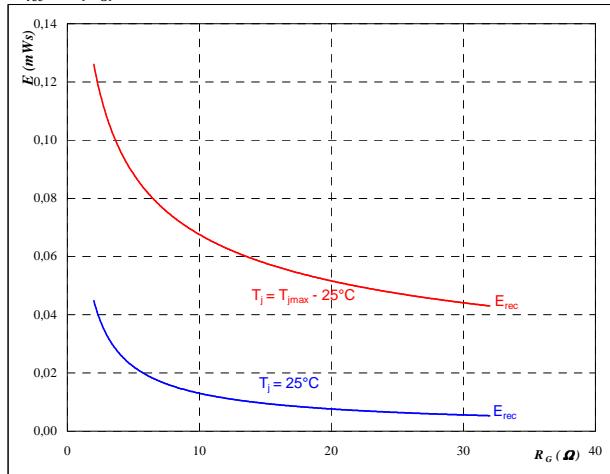
$$R_{gon} = 8 \text{ } \Omega$$

$$R_{goff} = 8 \text{ } \Omega$$

figure 8. Boost Switch (T1*, T2, T3)

Typical reverse recovery energy loss
as a function of gate resistor

$$E_{rec} = f(R_G)$$



With an inductive load at

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_{DS} = 400 \text{ V}$$

$$V_{GS} = 0/10 \text{ V}$$

$$I_D = 15 \text{ A}$$

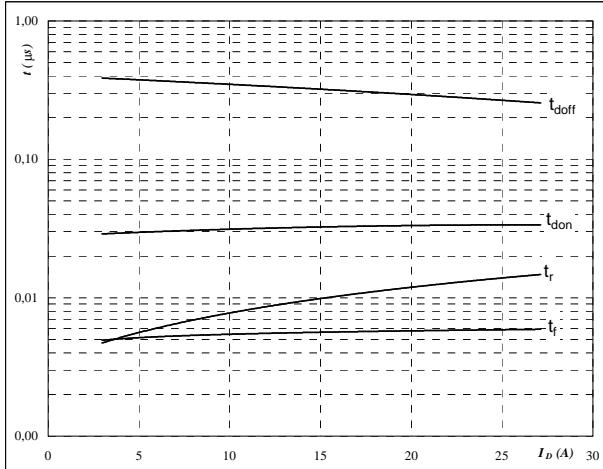
Boost Switch (T1*, T2, T3) / Boost Diode (D1*, D2, D3)

*not assembled in 10-FZ06B2A040MF01-M575L28

figure 9. Boost Switch (T1*, T2, T3)

Typical switching times as a function of drain current

$$t = f(I_D)$$



With an inductive load at

$$T_j = 125 \text{ } ^\circ\text{C}$$

$$V_{DS} = 400 \text{ V}$$

$$V_{GS} = 0/10 \text{ V}$$

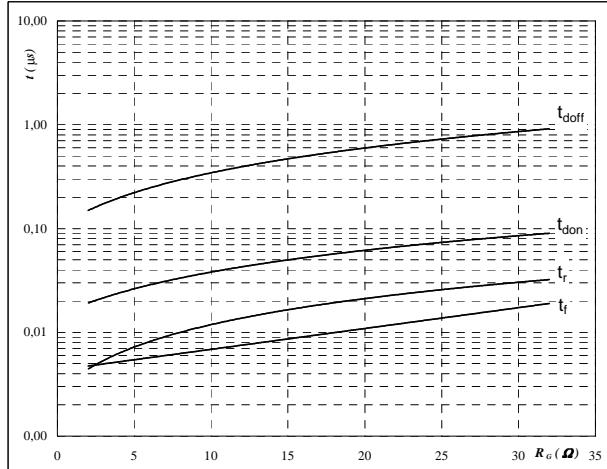
$$R_{gon} = 8 \text{ } \Omega$$

$$R_{goff} = 8 \text{ } \Omega$$

figure 10. Boost Switch (T1*, T2, T3)

Typical switching times as a function of gate resistor

$$t = f(R_G)$$



With an inductive load at

$$T_j = 125 \text{ } ^\circ\text{C}$$

$$V_{DS} = 400 \text{ V}$$

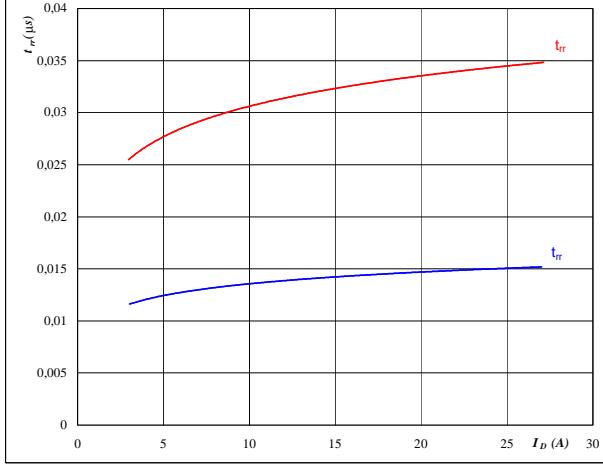
$$V_{GS} = 0/10 \text{ V}$$

$$I_D = 15 \text{ A}$$

figure 11. Boost Diode (D1*, D2, D3)

Typical reverse recovery time as a function of drain current

$$t_{rr} = f(I_c)$$



At

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_{DS} = 400 \text{ V}$$

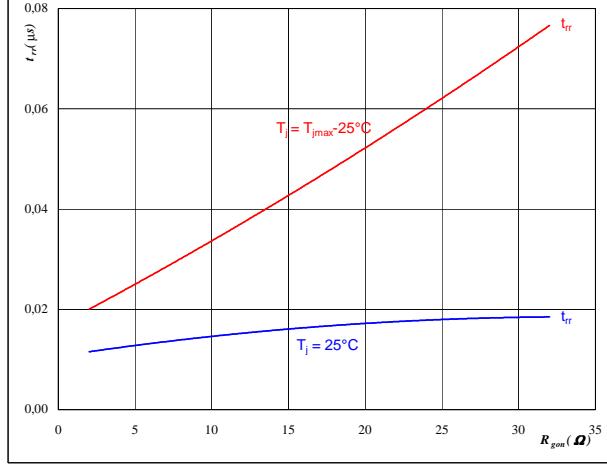
$$V_{GS} = 0/10 \text{ V}$$

$$R_{gon} = 8 \text{ } \Omega$$

figure 12. Boost Diode (D1*, D2, D3)

Typical reverse recovery time as a function of MOSFET turn on gate resistor

$$t_{rr} = f(R_{gon})$$



At

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_R = 400 \text{ V}$$

$$I_F = 15 \text{ A}$$

$$V_{GS} = 0/10 \text{ V}$$



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10-FZ06B2A040MF01-M575L28**

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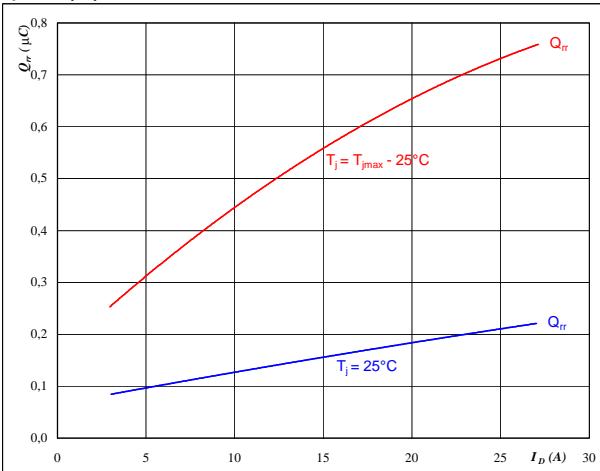
Boost Switch (T1*, T2, T3) / Boost Diode (D1*, D2, D3)

*not assembled in 10-FZ06B2A040MF01-M575L28

figure 13.**Boost Diode (D1*, D2, D3)**

Typical reverse recovery charge as a function of drain current

$$Q_{rr} = f(I_D)$$

**At**

$$T_j = \textcolor{blue}{25/125} \quad ^\circ\text{C}$$

$$V_{DS} = 400 \quad \text{V}$$

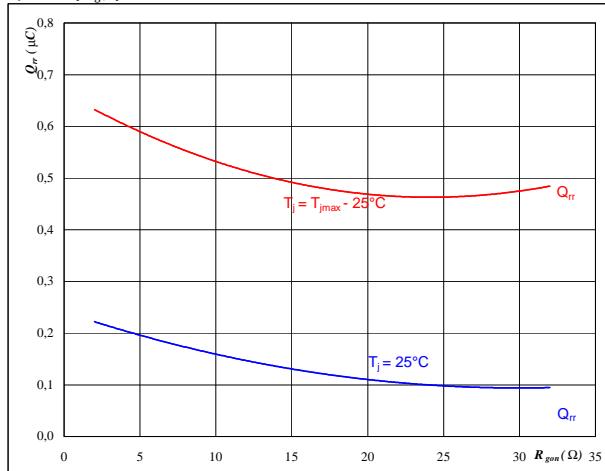
$$V_{GS} = 0/10 \quad \text{V}$$

$$R_{gon} = 8 \quad \Omega$$

figure 14.**Boost Diode (D1*, D2, D3)**

Typical reverse recovery charge as a function of MOSFET turn on gate resistor

$$Q_{rr} = f(R_{gon})$$

**At**

$$T_j = \textcolor{blue}{25/125} \quad ^\circ\text{C}$$

$$V_R = 400 \quad \text{V}$$

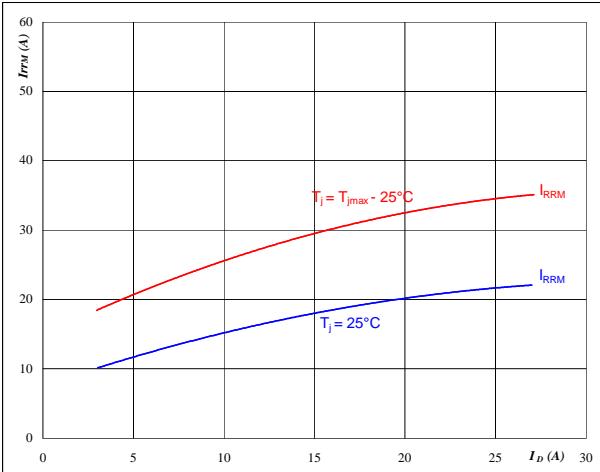
$$I_F = 15 \quad \text{A}$$

$$V_{GS} = 0/10 \quad \text{V}$$

figure 15.**Boost Diode (D1*, D2, D3)**

Typical reverse recovery current as a function of drain current

$$I_{RRM} = f(I_D)$$

**At**

$$T_j = \textcolor{blue}{25/125} \quad ^\circ\text{C}$$

$$V_{DS} = 400 \quad \text{V}$$

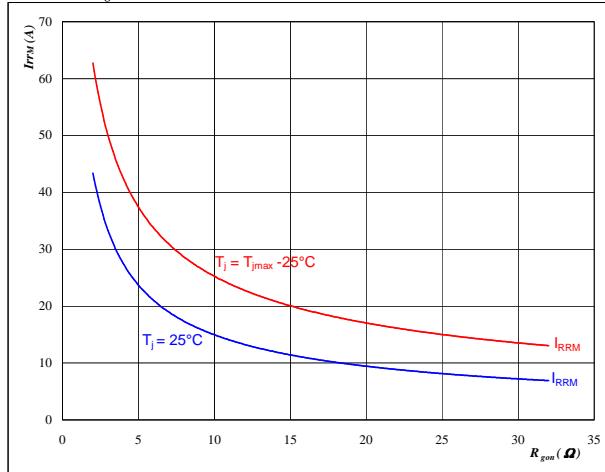
$$V_{GS} = 0/10 \quad \text{V}$$

$$R_{gon} = 8 \quad \Omega$$

figure 16.**Boost Diode (D1*, D2, D3)**

Typical reverse recovery current as a function of MOSFET turn on gate resistor

$$I_{RRM} = f(R_{gon})$$

**At**

$$T_j = \textcolor{blue}{25/125} \quad ^\circ\text{C}$$

$$V_R = 400 \quad \text{V}$$

$$I_F = 15 \quad \text{A}$$

$$V_{GS} = 0/10 \quad \text{V}$$

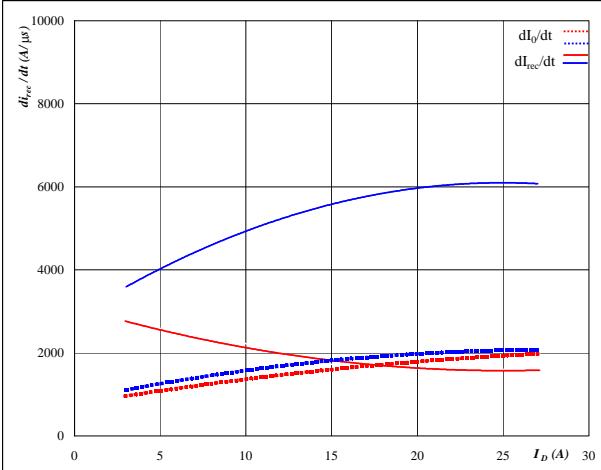
Boost Switch (T1*, T2, T3) / Boost Diode (D1*, D2, D3)

*not assembled in 10-FZ06B2A040MF01-M575L28

figure 17. **Boost Diode (D1*, D2, D3)**

**Typical rate of fall of forward
and reverse recovery current as a
function of drain current**

$$dI_0/dt, dI_{rec}/dt = f(I_D)$$



At

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_{DS} = 400 \text{ V}$$

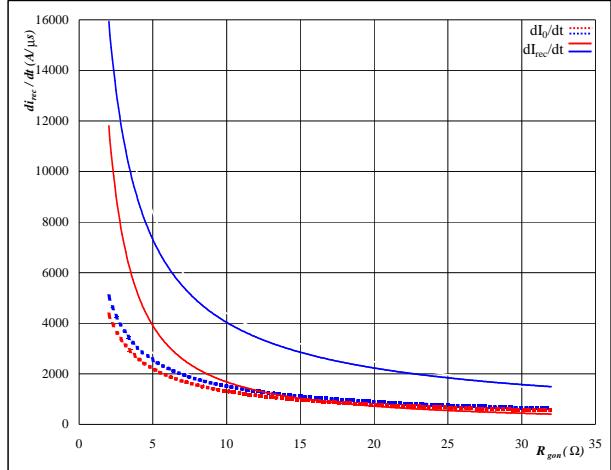
$$V_{GS} = 0/10 \text{ V}$$

$$R_{gon} = 8 \Omega$$

figure 18. **Boost Diode (D1*, D2, D3)**

**Typical rate of fall of forward
and reverse recovery current as a
function of MOSFET turn on gate resistor**

$$dI_0/dt, dI_{rec}/dt = f(R_{gon})$$



At

$$T_j = 25/125 \text{ } ^\circ\text{C}$$

$$V_R = 400 \text{ V}$$

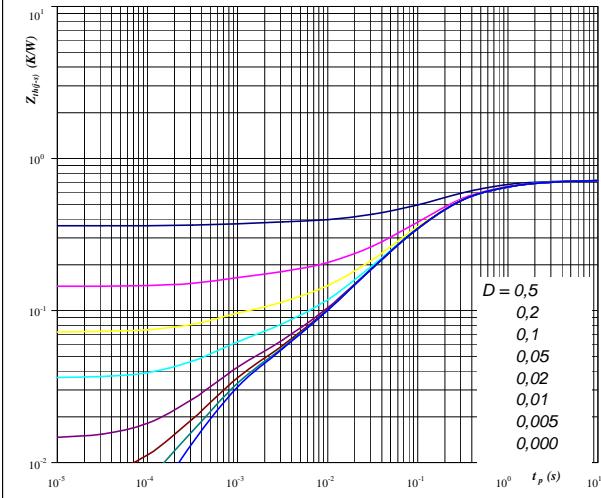
$$I_F = 15 \text{ A}$$

$$V_{GS} = 0/10 \text{ V}$$

figure 19. **Boost Switch (T1*, T2, T3)**

**MOSFET transient thermal impedance
as a function of pulse width**

$$Z_{th(j-s)} = f(t_p)$$



At

$$D = t_p / T$$

$$R_{th(j-s)} = 0,72 \text{ K/W}$$

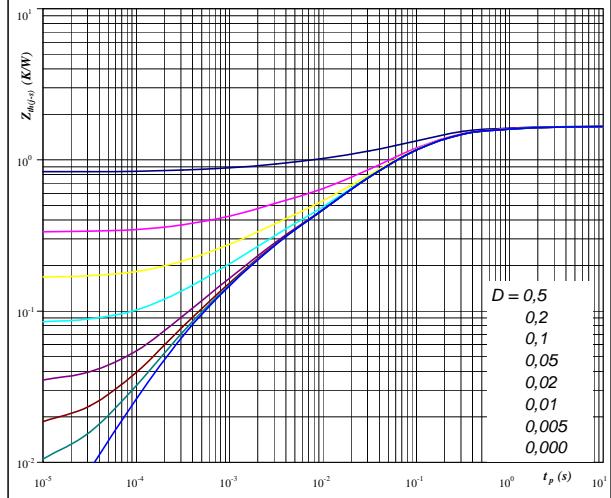
IGBT thermal model values

R (K/W)	τ (s)
1,89E-02	8,77E+00
1,06E-01	1,31E+00
3,52E-01	2,19E-01
1,64E-01	6,50E-02
4,91E-02	1,06E-02
3,08E-02	7,41E-04

figure 20. **Boost Diode (D1*, D2, D3)**

**FWD transient thermal impedance
as a function of pulse width**

$$Z_{th(j-s)} = f(t_p)$$



At

$$D = t_p / T$$

$$R_{th(j-s)} = 1,67 \text{ K/W}$$

FWD thermal model values

R (K/W)	τ (s)
6,19E-02	3,60E+00
2,39E-01	4,21E-01
8,36E-01	8,48E-02
3,20E-01	1,50E-02
1,67E-01	1,83E-03
4,64E-02	2,72E-04



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10-FZ06B2A040MF01-M575L28

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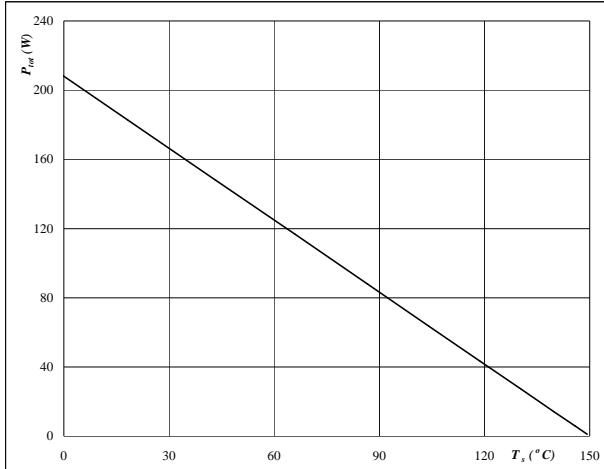
Boost Switch (T1*, T2, T3) / Boost Diode (D1*, D2, D3)

*not assembled in 10-FZ06B2A040MF01-M575L28

figure 21.**Boost Switch (T1*, T2, T3)**

**Power dissipation as a
function of heatsink temperature**

$$P_{\text{tot}} = f(T_s)$$

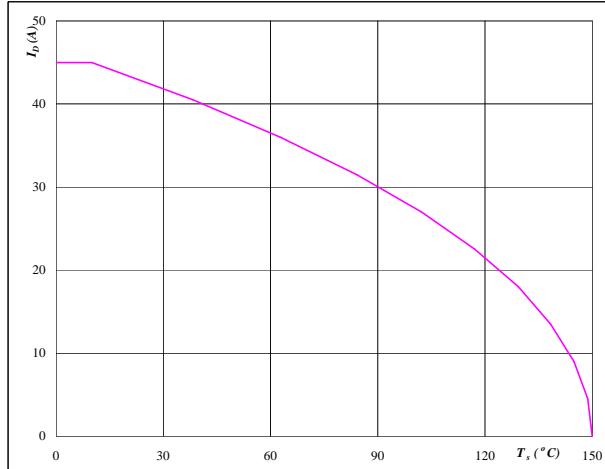
**At**

$$T_j = 150 \text{ } ^\circ\text{C}$$

figure 22.**Boost Switch (T1*, T2, T3)**

**Collector/Drain current as a
function of heatsink temperature**

$$I_D = f(T_s)$$

**At**

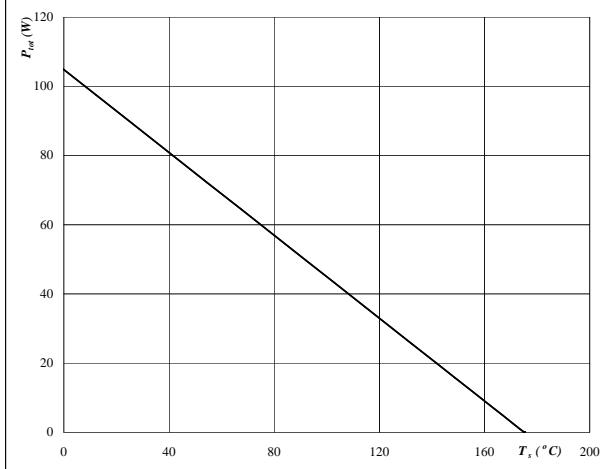
$$T_j = 150 \text{ } ^\circ\text{C}$$

$$V_{GS} = 10 \text{ V}$$

figure 23.**Boost Diode (D1*, D2, D3)**

**Power dissipation as a
function of heatsink temperature**

$$P_{\text{tot}} = f(T_s)$$

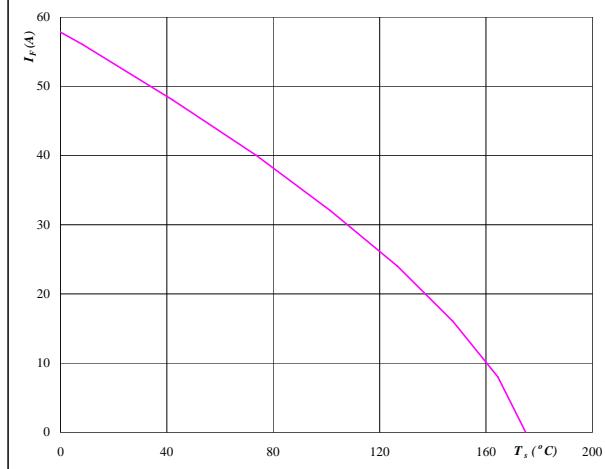
**At**

$$T_j = 175 \text{ } ^\circ\text{C}$$

figure 24.**Boost Diode (D1*, D2, D3)**

**Forward current as a
function of heatsink temperature**

$$I_F = f(T_s)$$

**At**

$$T_j = 175 \text{ } ^\circ\text{C}$$



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10-FZ06B2A040MF01-M575L28

datasheet

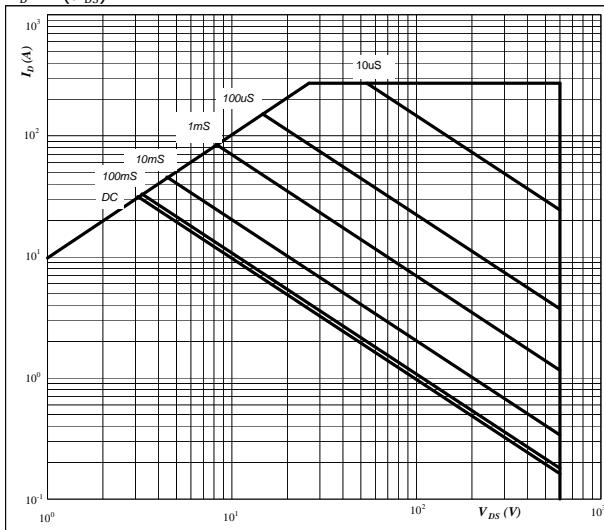
Boost Switch (T1*, T2, T3) / Boost Diode (D1*, D2, D3)

*not assembled in 10-FZ06B2A040MF01-M575L28

figure 25.**Boost Switch (T1*, T2, T3)**

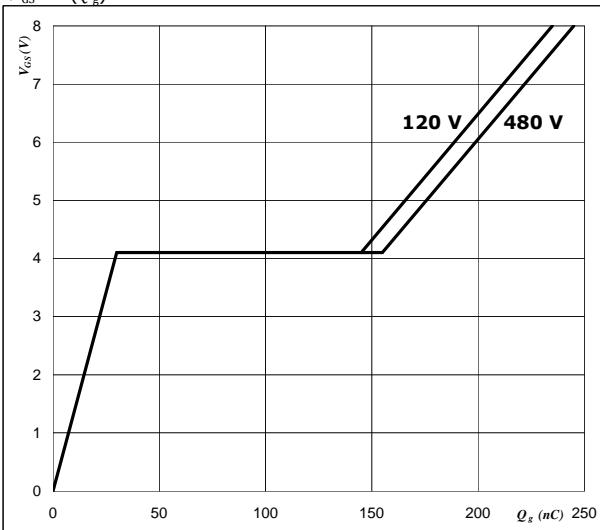
**Safe operating area as a function
of drain-source voltage**

$$I_D = f(V_{DS})$$

**At** $I_D = \text{single pulse}$ $T_s = 80 \text{ } ^\circ\text{C}$ $V_{GS} = 0/10 \text{ V}$ $T_j = T_{jmax}$ **figure 26.****Boost Switch (T1*, T2, T3)**

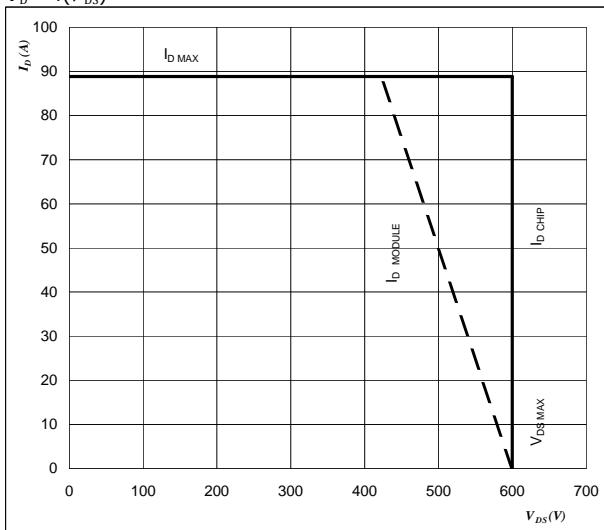
Gate voltage vs Gate charge

$$V_{GS} = f(Q_g)$$

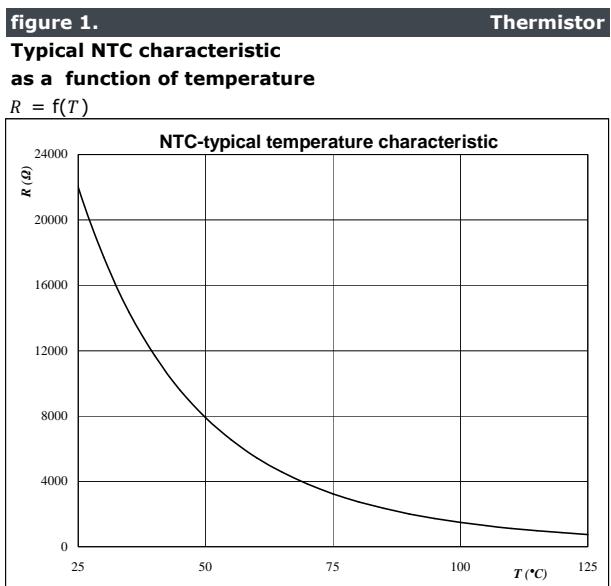
**At** $I_D = 50 \text{ A}$ **figure 27.****Boost Switch (T1*, T2, T3)**

Reverse bias safe operating area

$$I_D = f(V_{DS})$$

**At** $T_j = 150 \text{ } ^\circ\text{C}$ $R_{gon} = 8 \Omega$ $R_{goff} = 8 \Omega$

Thermistor



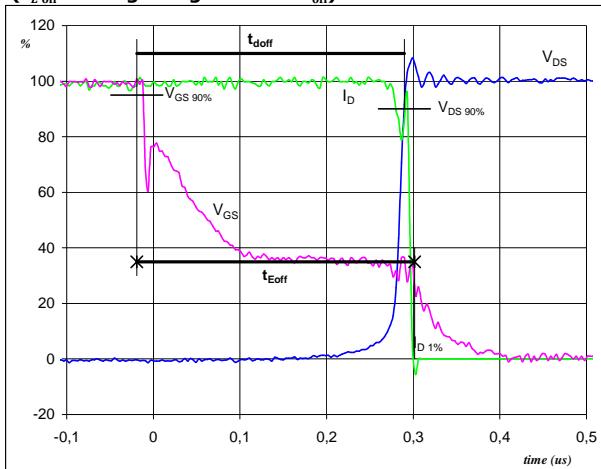
Switching Definitions Boost

General conditions

T_j	= 125 °C
R_{gon}	= 8 Ω
R_{goff}	= 8 Ω

figure 1.**Boost Switch**

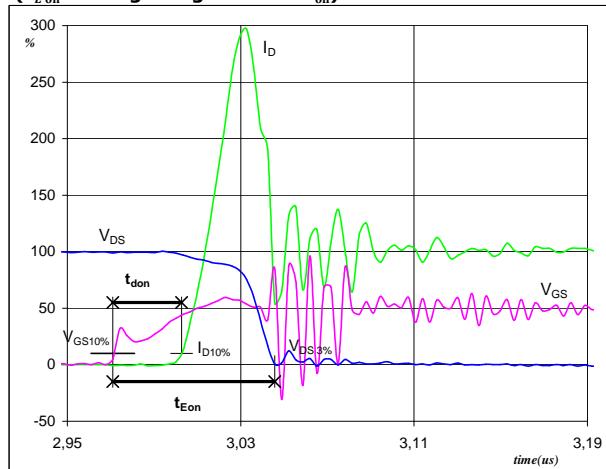
Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff}
 $(t_{Eoff} = \text{integrating time for } E_{off})$



$V_{GS\ (0\%)} = 0 \text{ V}$
 $V_{GS\ (100\%)} = 10 \text{ V}$
 $V_D\ (100\%) = 400 \text{ V}$
 $I_D\ (100\%) = 15 \text{ A}$
 $t_{doff} = 0,30 \mu\text{s}$
 $t_{Eoff} = 0,32 \mu\text{s}$

figure 2.**Boost Switch**

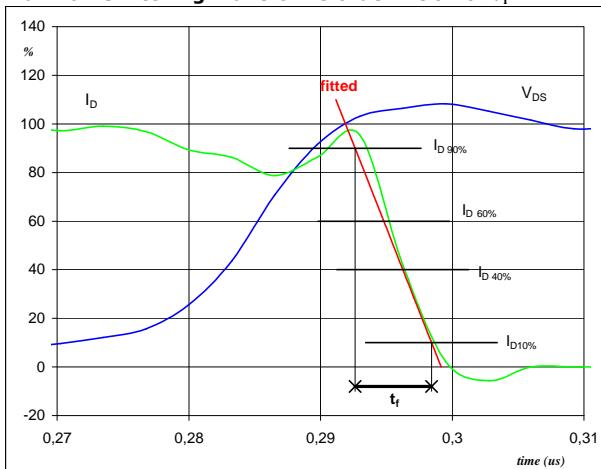
Turn-on Switching Waveforms & definition of t_{don} , t_{Eon}
 $(t_{Eon} = \text{integrating time for } E_{on})$



$V_{GS\ (0\%)} = 0 \text{ V}$
 $V_{GS\ (100\%)} = 10 \text{ V}$
 $V_D\ (100\%) = 400 \text{ V}$
 $I_D\ (100\%) = 15 \text{ A}$
 $t_{don} = 0,03 \mu\text{s}$
 $t_{Eon} = 0,07 \mu\text{s}$

figure 3.**Boost Switch**

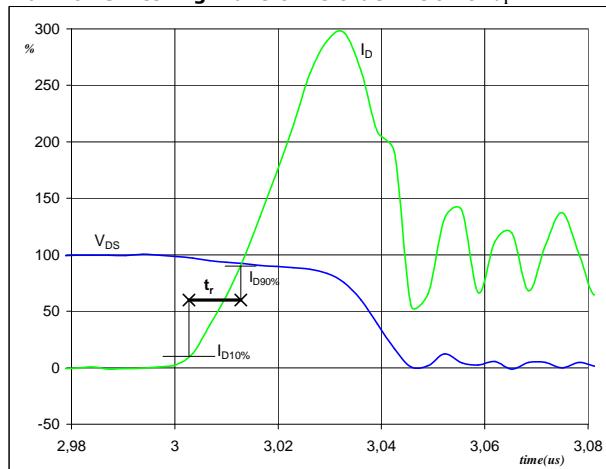
Turn-off Switching Waveforms & definition of t_f



$V_D\ (100\%) = 400 \text{ V}$
 $I_D\ (100\%) = 15 \text{ A}$
 $t_f = 0,00 \mu\text{s}$

figure 4.**Boost Switch**

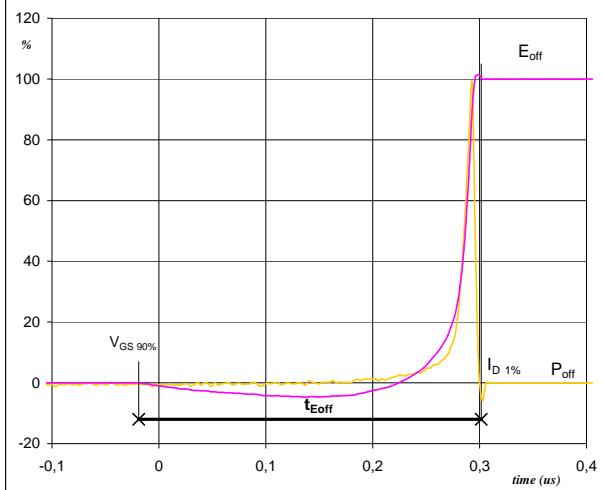
Turn-on Switching Waveforms & definition of t_r



$V_D\ (100\%) = 400 \text{ V}$
 $I_D\ (100\%) = 15 \text{ A}$
 $t_r = 0,01 \mu\text{s}$

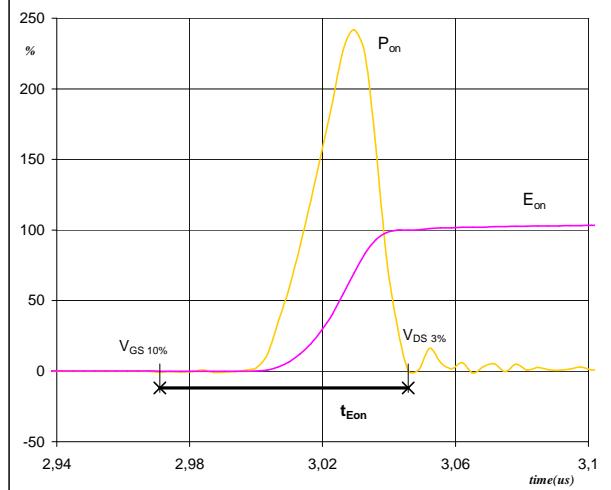
Switching Definitions Boost

figure 5. **Boost Switch**
Turn-off Switching Waveforms & definition of t_{Eoff}



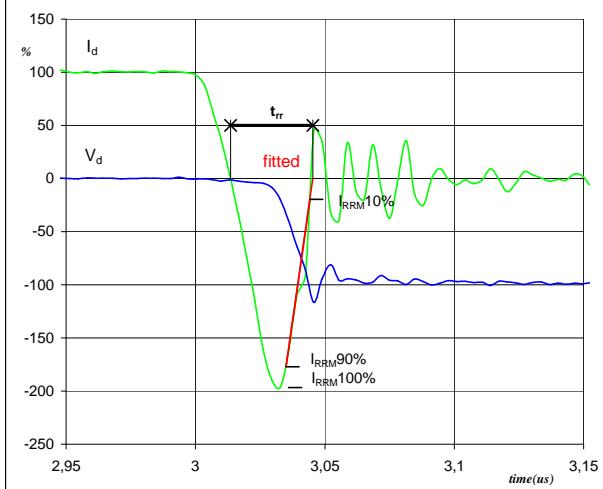
$P_{off} (100\%) = 6,02 \text{ kW}$
 $E_{off} (100\%) = 0,08 \text{ mJ}$
 $t_{Eoff} = 0,32 \mu\text{s}$

figure 6. **Boost Switch**
Turn-on Switching Waveforms & definition of t_{Eon}



$P_{on} (100\%) = 6,02 \text{ kW}$
 $E_{on} (100\%) = 0,34 \text{ mJ}$
 $t_{Eon} = 0,07 \mu\text{s}$

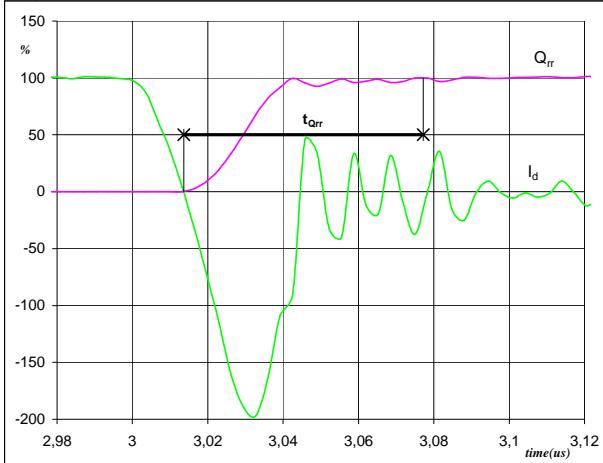
figure 7. **Boost Diode**
Turn-off Switching Waveforms & definition of t_{rr}



$V_d (100\%) = 400 \text{ V}$
 $I_d (100\%) = 15 \text{ A}$
 $I_{RRM} (100\%) = -30 \text{ A}$
 $t_{rr} = 0,03 \mu\text{s}$

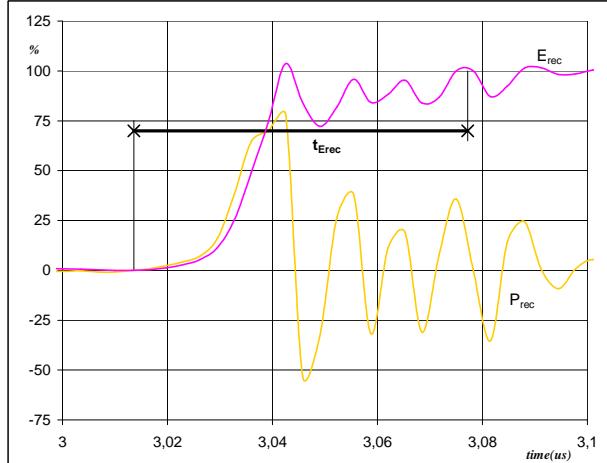
Switching Definitions Boost

figure 8. **Boost Diode**
Turn-on Switching Waveforms & definition of t_{Qrr}
 $(t_{Qrr} = \text{integrating time for } Q_{rr})$



I_d (100%) = 15 A
 Q_{rr} (100%) = 0,56 μC
 t_{Qrr} = 0,06 μs

figure 9. **Boost Diode**
Turn-on Switching Waveforms & definition of t_{Erec}
 $(t_{Erec} = \text{integrating time for } E_{rec})$



P_{rec} (100%) = 6,02 kW
 E_{rec} (100%) = 0,08 mJ
 t_{Erec} = 0,06 μs



Vincotech

10-FZ063BA040MF-M575L08
10-FZ06B2A040MF01-M575L28

datasheet

Ordering Code & Marking

Version	Ordering Code				
without thermal paste 12 mm housing with solder pins (triple booster)	10-FZ063BA040MF-M575L08				
without thermal paste 12 mm housing with solder pins (dual booster)	10-FZ06B2A040MF01-M575L28				
NN-NNNNNNNNNNNN TTTTTVV WWYY UL VIN LLLL SSSS					
Text	Name	Date code	UL & VIN	Lot	Serial
NN-NNNNNNNNNNNN-TTTTTVV	WWYY	UL VIN	LLLLL	SSSS	
Datamatrix	Type&Ver	Lot number	Serial	Date code	
TTTTTTVV	LLLLL	SSSS	WWYY		

Outline

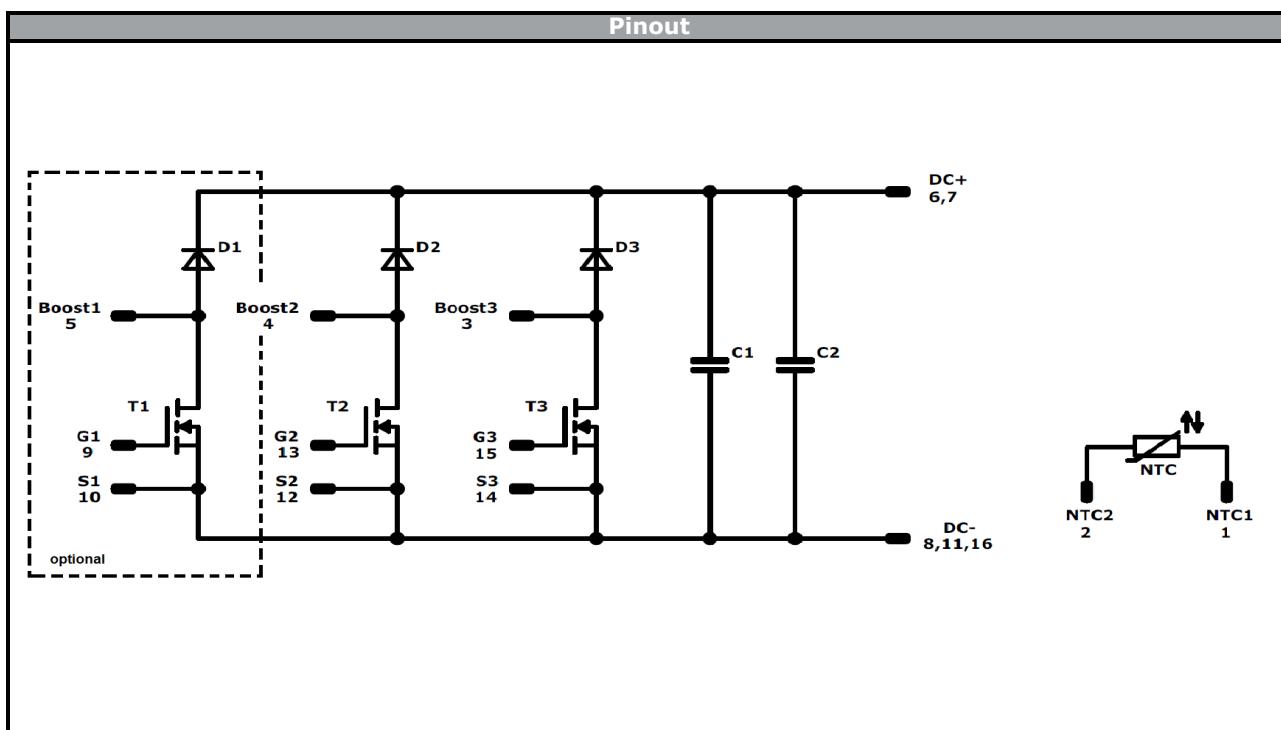
Pin table [mm]				Pinout variation	
Pin	X	Y	Function	Module subtype	Not assembled pins
1	33,3	0	NTC1	M575L28	5, 9, 10
2	30,7	0	NTC2		
3	23,85	0	Boost3		
4	15,95	0	Boost2		
5	9,6	0	Boost1		
6	2,6	0	DC+		
7	0	0	DC+		
8	0	22,3	DC-		
9	2,6	22,3	G1		
10	5,5	22,3	S1		
11	13,1	22,3	DC-		
12	15,9	22,3	S2		
13	19,4	22,3	G2		
14	27,7	22,3	S3		
15	30,7	22,3	G3		
16	33,3	22,3	DC-		

Tolerance of pinpositions +0.5mm at the end of pins
Dimension of coordinate axis is only offset without tolerance

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14

20 Jul. 2017 / Revision 4



Identification

ID	Component	Voltage	Current	Function	Comment
T1*, T2, T3	MOSFET	600 V	41 mΩ	Boost Switch	
D1*, D2, D3	FWD	600 V	30 A	Boost Diode	
C1, C2	Capacitor	630 V		DC Link Capacitance	
NTC	NTC			Thermistor	

*not assembled in 10-FZ06B2A040MF01-M575L28



Vincotech

**10-FZ063BA040MF-M575L08
10-FZ06B2A040MF01-M575L28**

datasheet

Packaging instruction		>SPQ	Standard	<SPQ	Sample
Standard packaging quantity (SPQ)	135				

Handling instruction
Handling instructions for <i>flow</i> 0 packages see vincotech.com website.

Package data
Package data for <i>flow</i> 0 packages see vincotech.com website.

UL recognition and file number
This device is certified according to UL 1557 standard, UL file number E192116. For more information see vincotech.com website. 

Document No.:	Date:	Modification:	Pages
10-FZ06xxA040MFxx-M575Lx8-D4-14	20 Jul. 2017		

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.